

Dual N-channel 20V, TSSOP-8 MOSFET 双 N-溝道場效應管

■ Features 特點

Low on-resistance and maximum DC current capability 低導通電阻和最大直流電流能力

Super high density cell design 超高元胞密度設計

$R_{DS(ON)} \leq 25\text{m}\Omega @ V_{GS} = 4.5\text{V}$

$R_{DS(ON)} \leq 40\text{m}\Omega @ V_{GS} = 2.5\text{V}$

■ Applications 應用

Power Management in Note book 筆記本電源管理

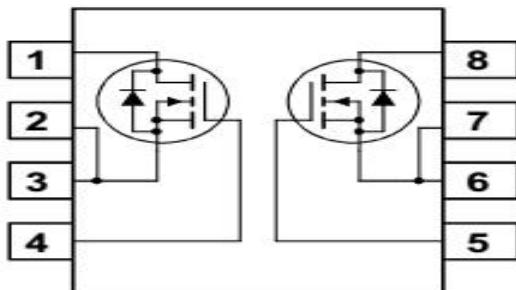
Portable Equipment 便攜式設備

Battery Powered System 電池電源系統

DC/DC Converter 直流/直流變換

Load Switch 負載開關應用

■ Internal Schematic Diagram 內部結構



■ Absolute Maximum Ratings 最大額定值

Characteristic 特性參數	Symbol 符號	Rating 額定值	Unit 單位
Drain-Source Voltage 漏極-源極電壓	BV_{DSS}	20	V
Gate- Source Voltage 柵極-源極電壓	V_{GS}	± 8	V
Drain Current (continuous)漏極電流-連續	I_D	5.0	A
Drain Current (pulsed)漏極電流-脉冲	I_{DM}	20	A
Total Device Dissipation 總耗散功率 (at $TC = 25^\circ\text{C}$) (at $TC = 70^\circ\text{C}$)	P_{TOT}	2 1.6	W
Thermal Resistance Junction-Ambient 热阻	$R_{\Theta JA}$	78	$^\circ\text{C}/\text{W}$
Thermal Resistance Junction-Case 热阻	$R_{\Theta JC}$	40	$^\circ\text{C}/\text{W}$
Junction/Storage Temperature 結溫/儲存溫度	T_J, T_{stg}	-55~150	$^\circ\text{C}$

■ Electrical Characteristics 電特性

($T_A=25^\circ\text{C}$ unless otherwise noted 如無特殊說明，溫度為 25°C)

Characteristic 特性參數	Symbol 符號	Min 最小值	Typ 典型值	Max 最大值	Unit 單位
Drain-Source Breakdown Voltage 漏極-源極擊穿電壓($I_D = 250\mu\text{A}$, $V_{GS} = 0\text{V}$)	BV_{DSS}	20	—	—	V
Gate Threshold Voltage 柵極開启電壓($I_D = 250\mu\text{A}$, $V_{GS} = V_{DS}$)	$V_{GS(\text{th})}$	0.5	—	1.0	V
Zero Gate Voltage Drain Current 零柵壓漏極電流($V_{GS} = 0\text{V}$, $V_{DS} = 20\text{V}$)	I_{DSS}	—	—	1	μA
Gate Body Leakage 柵極漏電流($V_{GS} = \pm 8\text{V}$, $V_{DS} = 0\text{V}$)	I_{GSS}	—	—	± 100	nA
Static Drain-Source On-State Resistance 静态漏源導通電阻($I_D = 5\text{A}$, $V_{GS} = 4.5\text{V}$) ($I_D = 3\text{A}$, $V_{GS} = 2.5\text{V}$)	$R_{DS(\text{ON})}$	—	24 35	25 40	$\text{m}\Omega$
Diode Forward Voltage Drop 內附二極管正向壓降($I_{SD} = 1.7\text{A}$, $V_{GS} = 0\text{V}$)	V_{SD}	—	—	1.2	V
Input Capacitance 輸入電容 ($V_{GS} = 0\text{V}$, $V_{DS} = 10\text{V}$, $f = 1\text{MHz}$)	C_{ISS}	—	600	—	pF
Common Source Output Capacitance 共源輸出電容($V_{GS} = 0\text{V}$, $V_{DS} = 10\text{V}$, $f = 1\text{MHz}$)	C_{OSS}	—	90	—	pF
Reverse Transfer Capacitance 反向傳輸電容 ($V_{GS} = 0\text{V}$, $V_{DS} = 10\text{V}$, $f = 1\text{MHz}$)	C_{RSS}	—	40	—	pF
Gate Source Charge 柵源電荷密度 ($V_{DS} = 10\text{V}$, $I_D = 3\text{A}$, $V_{GS} = 4.5\text{V}$)	Q_{gs}	—	1.2	—	nC
Gate Drain Charge 柵漏電荷密度 ($V_{DS} = 10\text{V}$, $I_D = 3\text{A}$, $V_{GS} = 4.5\text{V}$)	Q_{gd}	—	1.9	—	nC
Turn-On Delay Time 開啟延遲時間 ($V_{DS} = 10\text{V}$, $I_D = 1\text{A}$, $R_{GEN} = 6\Omega$, $V_{GS} = 4.5\text{V}$)	$t_{d(on)}$	—	8	—	ns
Turn-On Rise Time 開啟上升時間 ($V_{DS} = 10\text{V}$, $I_D = 1\text{A}$, $R_{GEN} = 6\Omega$, $V_{GS} = 4.5\text{V}$)	t_r	—	10	—	ns
Turn-Off Delay Time 關斷延遲時間 ($V_{DS} = 10\text{V}$, $I_D = 1\text{A}$, $R_{GEN} = 6\Omega$, $V_{GS} = 4.5\text{V}$)	$t_{d(off)}$	—	18	—	ns
Turn-On Fall Time 開啟下降時間 ($V_{DS} = 10\text{V}$, $I_D = 1\text{A}$, $R_{GEN} = 6\Omega$, $V_{GS} = 4.5\text{V}$)	t_f	—	5	—	ns

■ TYPICAL CHARACTERISTIC CURVE(PER DIE)

典型特性曲线

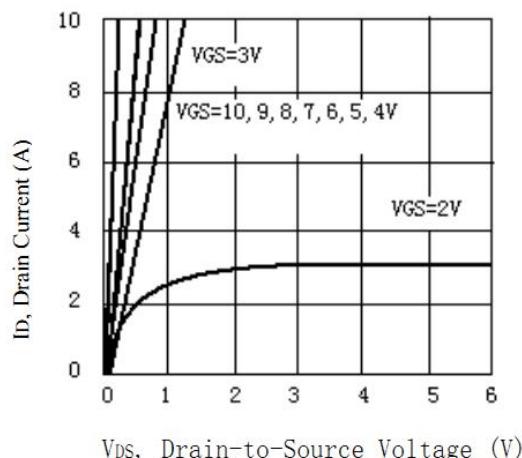


Fig 1: Output Characteristics

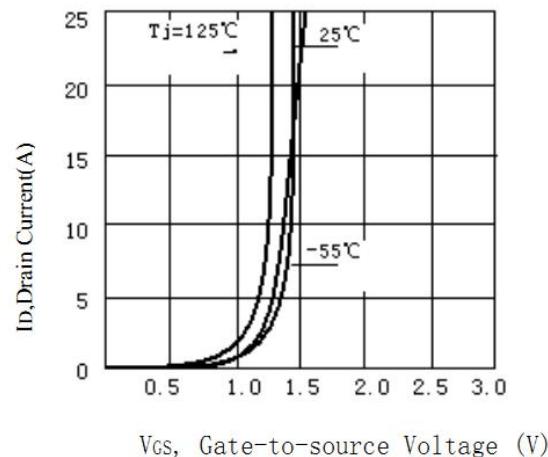


Figure 2: Transfer Characteristics

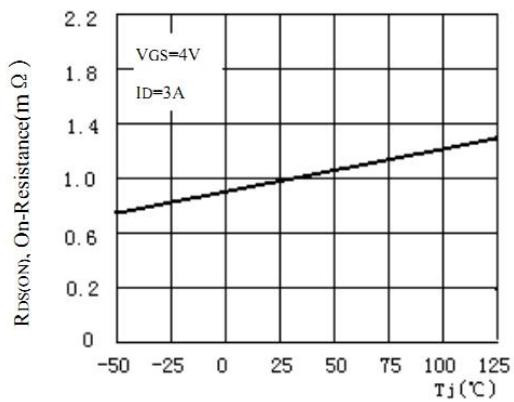


Figure 3: On-Resistance vs. Temperature

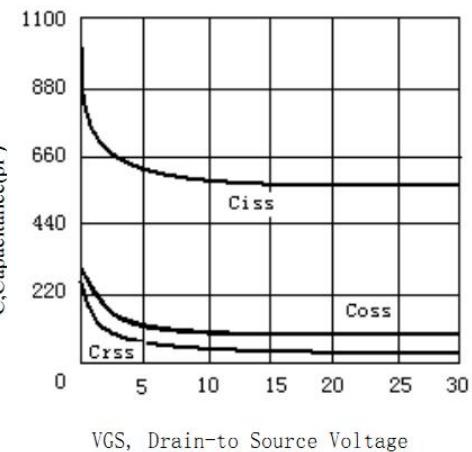


Figure 4: Capacitance vs. Gate-Source Voltage

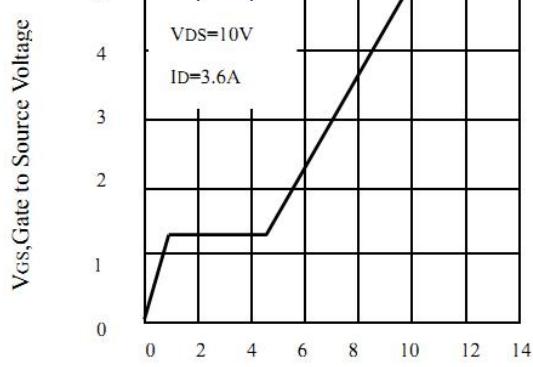


Figure 5: Gate-Charge Characteristics

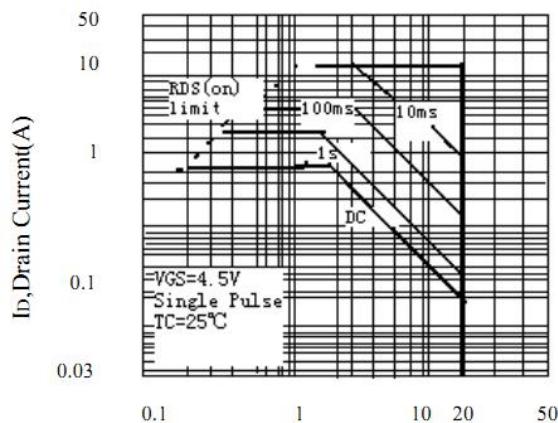
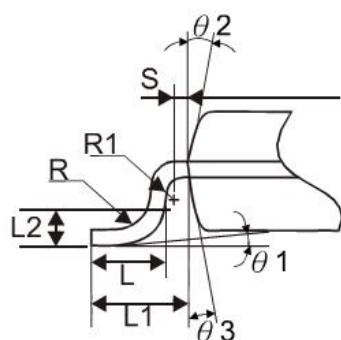
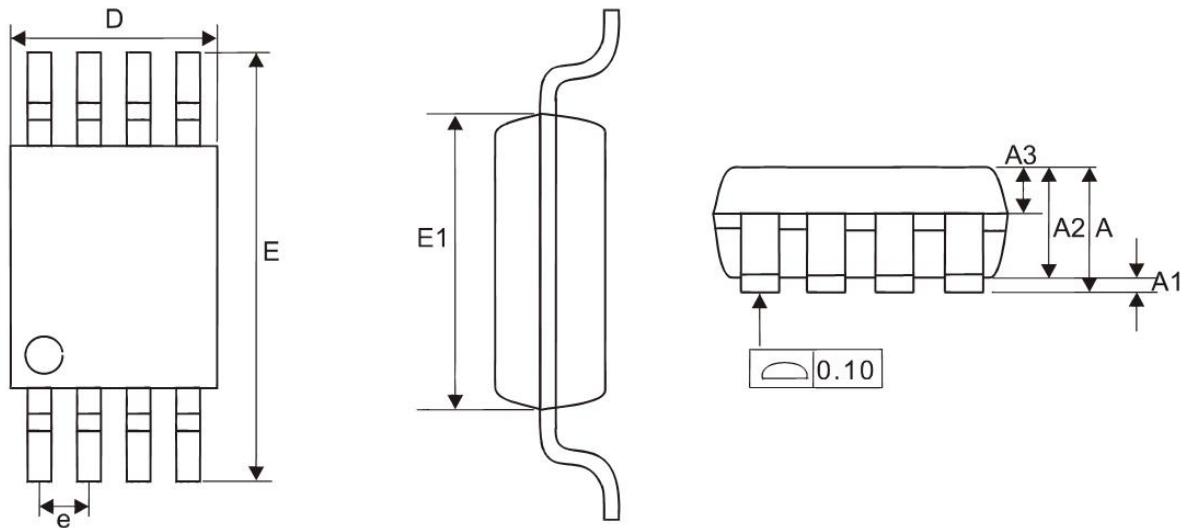


Figure 6: Safe Operating Area

■DIMENSION 外形封裝尺寸



SYMBOL	MILLIMETERS	
	MIN	MAX
A	-	1.20
A1	0.05	0.15
A2	0.90	1.05
A3	0.34	0.54
D	2.90	3.10
E	6.20	6.60
E1	4.30	4.50
e	0.65BSC	
L	0.45	0.75
L1	1.00REF	
L2	0.25BSC	
R	0.09	-
R1	0.09	-
S	0.20	-
theta 1	0"	8"
theta 2	10"	14"
theta 3	10"	14"

Note: 1. Refer to JEDEC MS-012AA.

2. Dimension "D" does not include mold flash, protrusions